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SUBSTITUTE FORM PTO-1449 (MODIFIED)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 04873/074001

SERIAL NO. 09/047,011

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary) APPLICANT Paul Dvorkis et al.

FILING DATE March 24, 1998 GROUP 2112

(37 CFR 1.98(b))

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	AC	5	4	4	0		1	1	1	08/08/95	Eastman et al.			062	
	AD	5	4	2	0		4	1	1	05/30/95	Salatto, Jr. et al.			20 E	
	AE	5	3	3	2		8	9	2	07/26/94	Li et al.		_	# C = 5	
	AF	5	2	8	0		1	6	1	01/18/94	Niwa			ř =	
	AG	5	2	5	0	T	7	9	1	10/05/93	Heiman, et al.				
	АН	5	2	3	5		1	6	7	08/10/93	Dvorkis, et al.				
	AI	5	2	2	9	1	5	9	1	07/20/93	Heiman, et al.				
	AJ	5	2	1	8	T	1	9	0	06/08/93	Hardesty, et al.				
	AK	5	2	0	0	1	5	9	7	04/06/93	Eastman et al.				
	AL	5	1	9	4		7	2	0	03/16/93	Reinnagel, et al.			<u> </u>	
	AM	5	1	7	0	ī	2	7	7	12/08/92	Bard et al.				
	AN	5	1	1	5	,	3	3	4	05/19/92	Tomita				
	AO	5	0	8	1	1	6	3	9	01/14/92	Synder et al.				
	AP	5	0	7	3	5	9	5	4	12/17/91	Van Tyne, et al.				
	AQ	5	0	6	7	7	0	9	3	11/19/91	Przybylowicz, et al.				
	AR	5	0	6	. 4	4	2	5	8	11/12/91	Inokuchi, et al.				
	AS	5	0	4		7	6	1	7	09/10/91	Shepard, et al.				
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> **GROUP** 2112

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	BR	4	5	3	8	8	9	9	5	09/03/85	Higgins, et al.			
	BS	4	5	0	8	6	. 8	В	6	04/02/85	Shaber, et al.			
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Grabowski, et al., "Code Reading Mechanical Scanning Gun", IBM Technical Disclosure Bulletin, Vol. 5, No. 5

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Substitute Disclosure Form (PTO-1449)

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. 04873/074001

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)

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APPLICANT Paul Dvorkis et al.

(37 CFR 1.98(b))

FILING DATE March 24, 1998 GROUP 2112

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